



SD56150

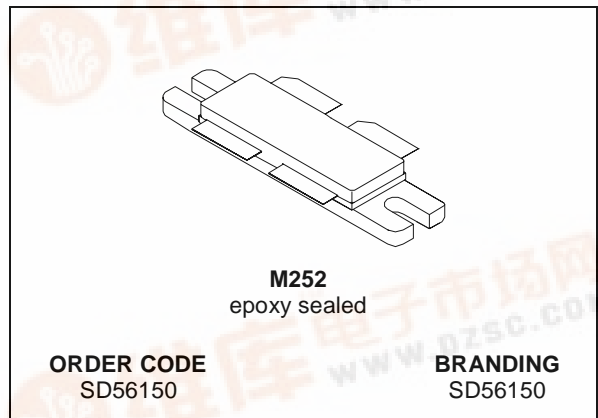
RF POWER TRANSISTORS

The *Ldmo*ST FAMILY

PRELIMINARY DATA

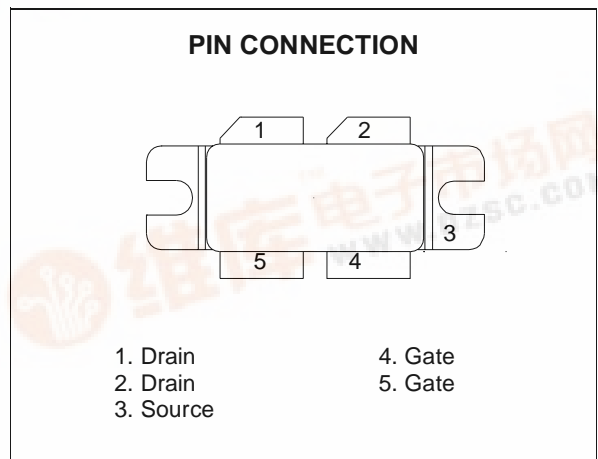
N-CHANNEL ENHANCEMENT-MODE LATERAL MOSFETs

- EXCELLENT THERMAL STABILITY
- COMMON SOURCE CONFIGURATION, PUSH-PULL
- P_{OUT} = 150 W WITH 13 dB gain @ 860 MHz /32V
- BeO FREE PACKAGE
- INTERNAL INPUT MATCHING



DESCRIPTION

The SD56150 is a common source N-Channel enhancement-mode lateral Field-Effect RF power transistor designed for broadband commercial and industrial applications at frequencies up to 1.0 GHz. The SD56150 is designed for high gain and broadband performance operating in common source mode at 32 V. Its internal matching makes it ideal for TV broadcast applications requiring high linearity.



ABSOLUTE MAXIMUM RATINGS (T_{CASE} = 25 °C)

| Symbol | Parameter | Value | Unit |
|----------------------|--|-------------|------|
| V _{(BR)DSS} | Drain-Source Voltage | 65 | V |
| V _{GS} | Gate-Source Voltage | ± 20 | V |
| I _D | Drain Current | 17 | A |
| P _{DISS} | Power Dissipation (@ T _c = 70 °C) | 236 | W |
| T _J | Max. Operating Junction Temperature | 200 | °C |
| T _{STG} | Storage Temperature | -65 to +150 | °C |

THERMAL DATA

| | | | |
|----------------------|-----------------------------------|------|------|
| R _{th(j-c)} | Junction -Case Thermal Resistance | 0.55 | °C/W |
|----------------------|-----------------------------------|------|------|



SD56150

ELECTRICAL SPECIFICATION ($T_{CASE} = 25\text{ }^{\circ}\text{C}$)

STATIC (Per Section)

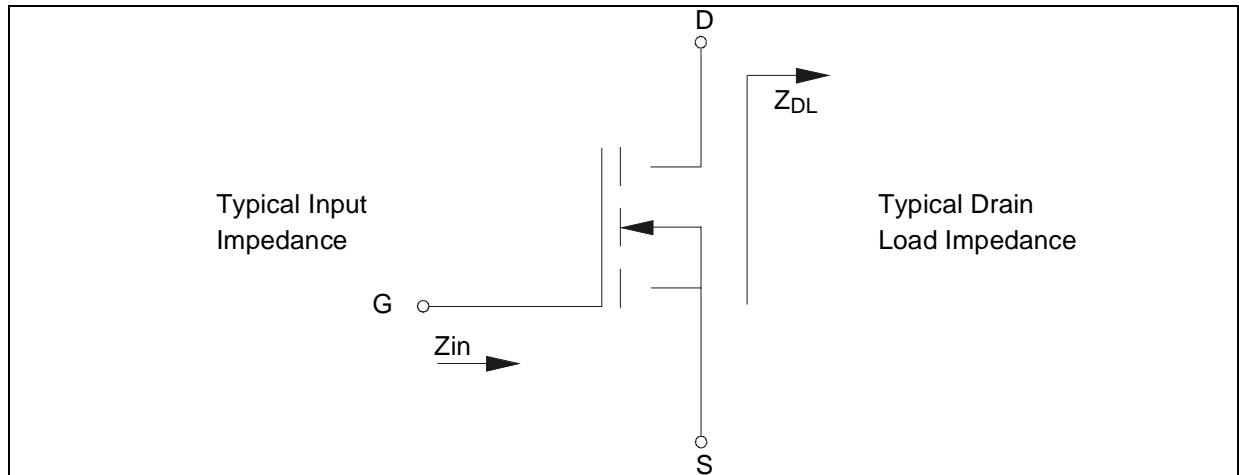
| Symbol | Test Conditions | | Min. | Typ. | Max. | Unit |
|---------------|------------------------|-------------------------|------|------|------|---------------|
| $V_{(BR)DSS}$ | $V_{GS} = 0\text{ V}$ | $I_{DS} = 10\text{ mA}$ | 65 | | | V |
| I_{DSS} | $V_{GS} = 0\text{ V}$ | $V_{DS} = 28\text{ V}$ | | | 1 | μA |
| I_{GSS} | $V_{GS} = 20\text{ V}$ | $V_{DS} = 0\text{ V}$ | | | 1 | μA |
| $V_{GS(Q)}$ | $V_{DS} = 28\text{ V}$ | $I_D = 100\text{ mA}$ | 2.0 | | 5.0 | V |
| $V_{DS(ON)}$ | $V_{GS} = 10\text{ V}$ | $I_D = 3\text{ A}$ | | 0.5 | 0.8 | V |
| G_{FS} | $V_{DS} = 10\text{ V}$ | $I_D = 3\text{ A}$ | 2.5 | | 4 | mho |
| C_{ISS}^* | $V_{GS} = 0\text{ V}$ | $V_{DS} = 28\text{ V}$ | | 255 | | pF |
| C_{OSS} | $V_{GS} = 0\text{ V}$ | $V_{DS} = 28\text{ V}$ | | 50 | | pF |
| C_{RSS} | $V_{GS} = 0\text{ V}$ | $V_{DS} = 28\text{ V}$ | | 2.9 | | pF |

* Includes Internal Input Moscap.

DYNAMIC

| Symbol | Test Conditions | | | | Min. | Typ. | Max. | Unit |
|---------------|------------------------|--------------------------|--------------------------|----------------------|------|------|------|------|
| P_{OUT} | $V_{DD} = 32\text{ V}$ | $I_{DQ} = 500\text{ mA}$ | | $f = 860\text{ MHz}$ | 150 | | | W |
| G_{PS} | $V_{DD} = 32\text{ V}$ | $I_{DQ} = 500\text{ mA}$ | $P_{OUT} = 150\text{ W}$ | $f = 860\text{ MHz}$ | 13 | 16.5 | | dB |
| η_D | $V_{DD} = 32\text{ V}$ | $I_{DQ} = 500\text{ mA}$ | $P_{OUT} = 150\text{ W}$ | $f = 860\text{ MHz}$ | 50 | 60 | | % |
| Load mismatch | $V_{DD} = 32\text{ V}$ | $I_{DQ} = 500\text{ mA}$ | $P_{OUT} = 150\text{ W}$ | $f = 860\text{ MHz}$ | 10:1 | | | VSWR |

IMPEDANCE DATA

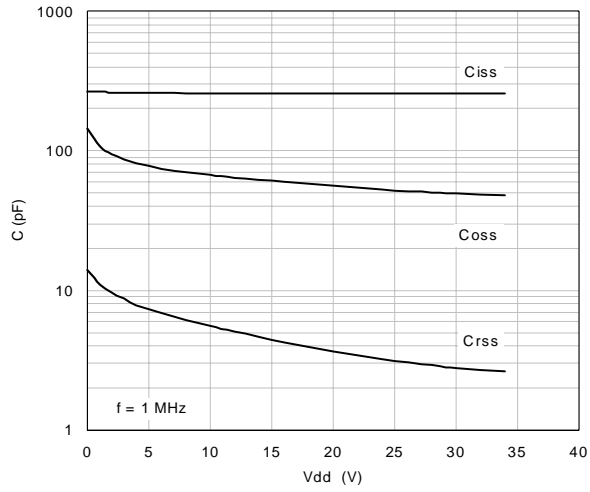


| FREQ. | $Z_{IN} (\Omega)$ | $Z_{DL} (\Omega)$ |
|---------|-------------------|-------------------|
| 860 MHz | $4.7 - j 5.5$ | $3.6 + j 6.5$ |
| 880 MHz | $4.3 - j 6.9$ | $3.9 + j 7.4$ |
| 900 MHz | $4.5 - j 8.8$ | $4.4 + j 7.8$ |

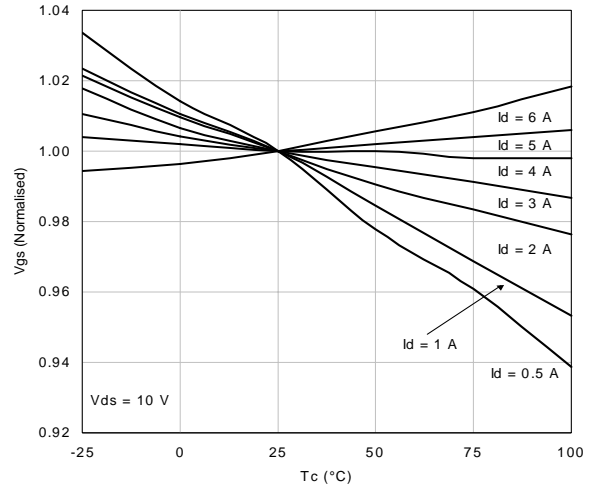
Measured drain to drain and gate to gate respectively.

TYPICAL PERFORMANCE

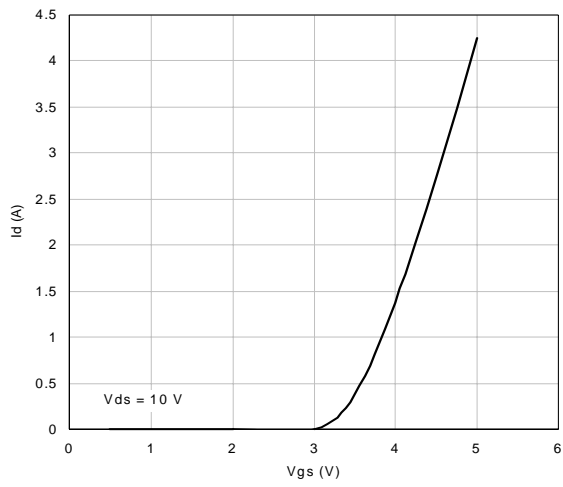
Capacitance vs. Drain Voltage



Gate Source Voltage vs. Case Temperature



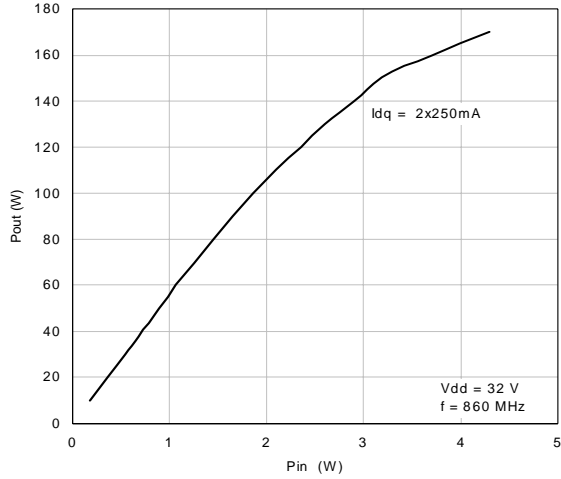
Drain Current vs. Gate-Source Voltage



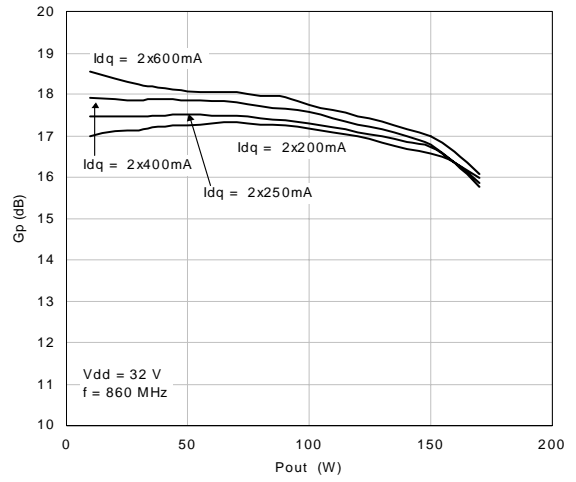
SD56150

TYPICAL PERFORMANCE

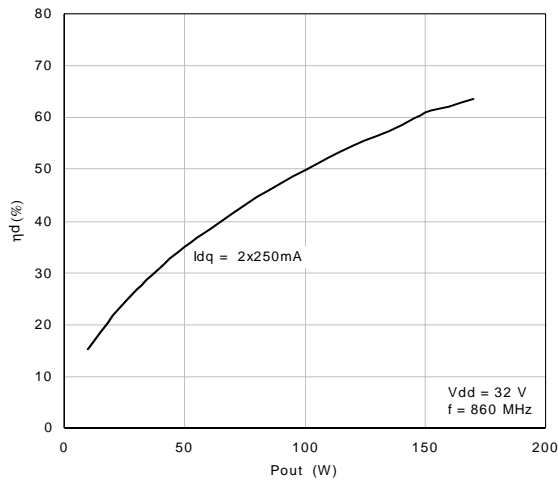
Output Power vs. Input Power



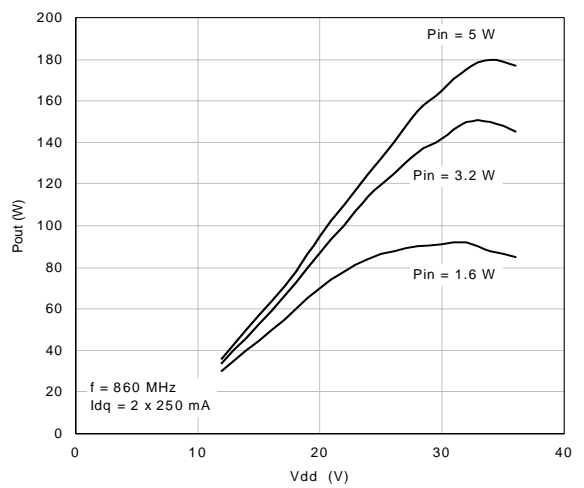
Power Gain vs. Output Power



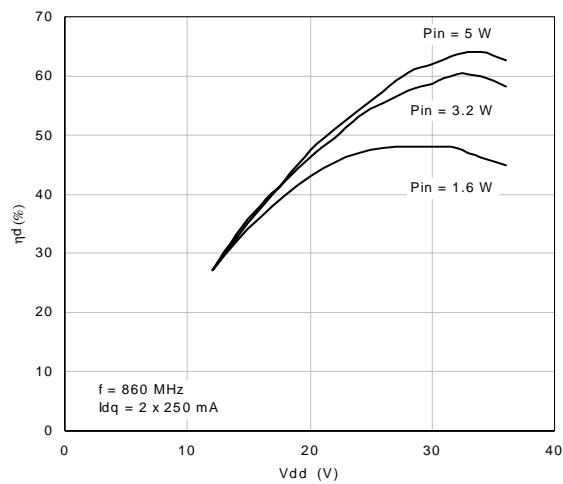
Efficiency vs. Output Power



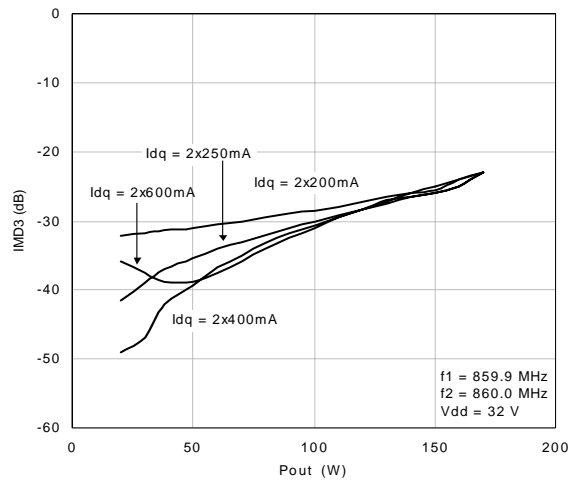
Output Power vs. Supply Voltage



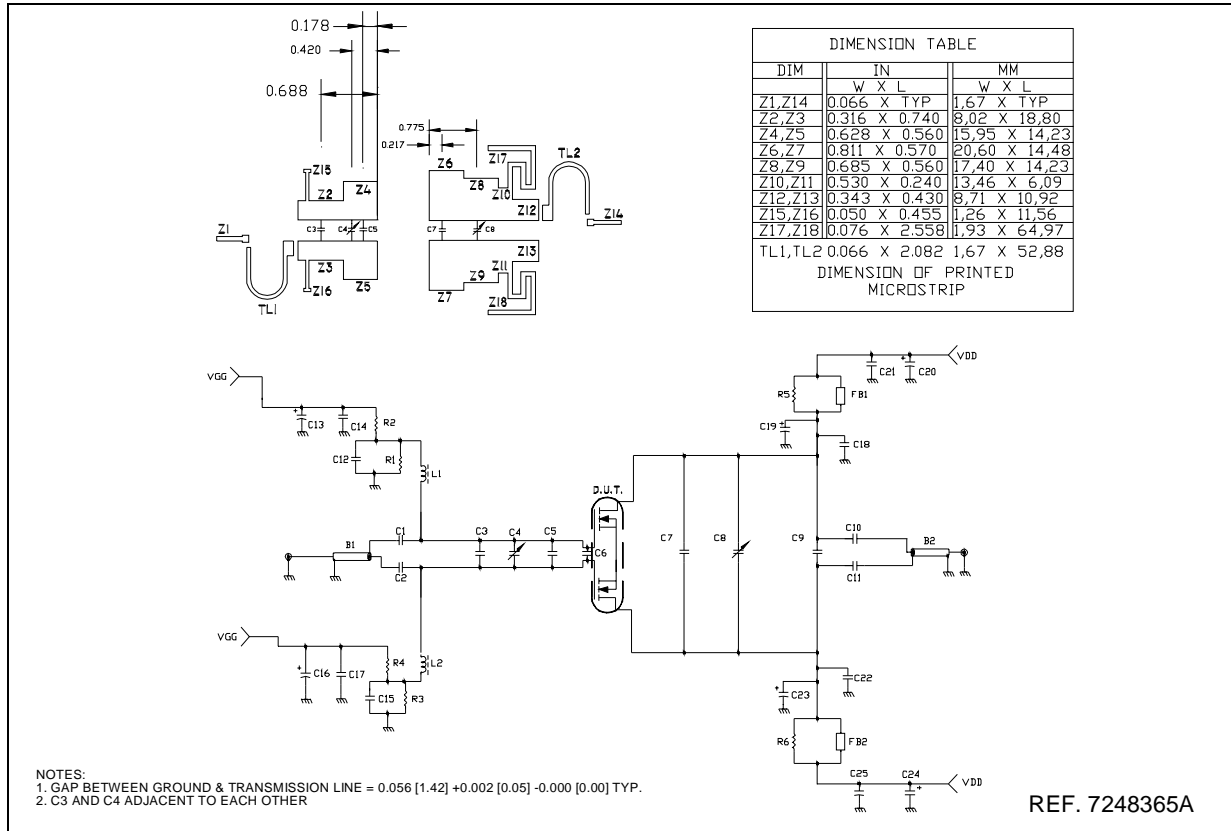
Efficiency vs. Supply Voltage



Intermodulation Distortion vs. Output Power



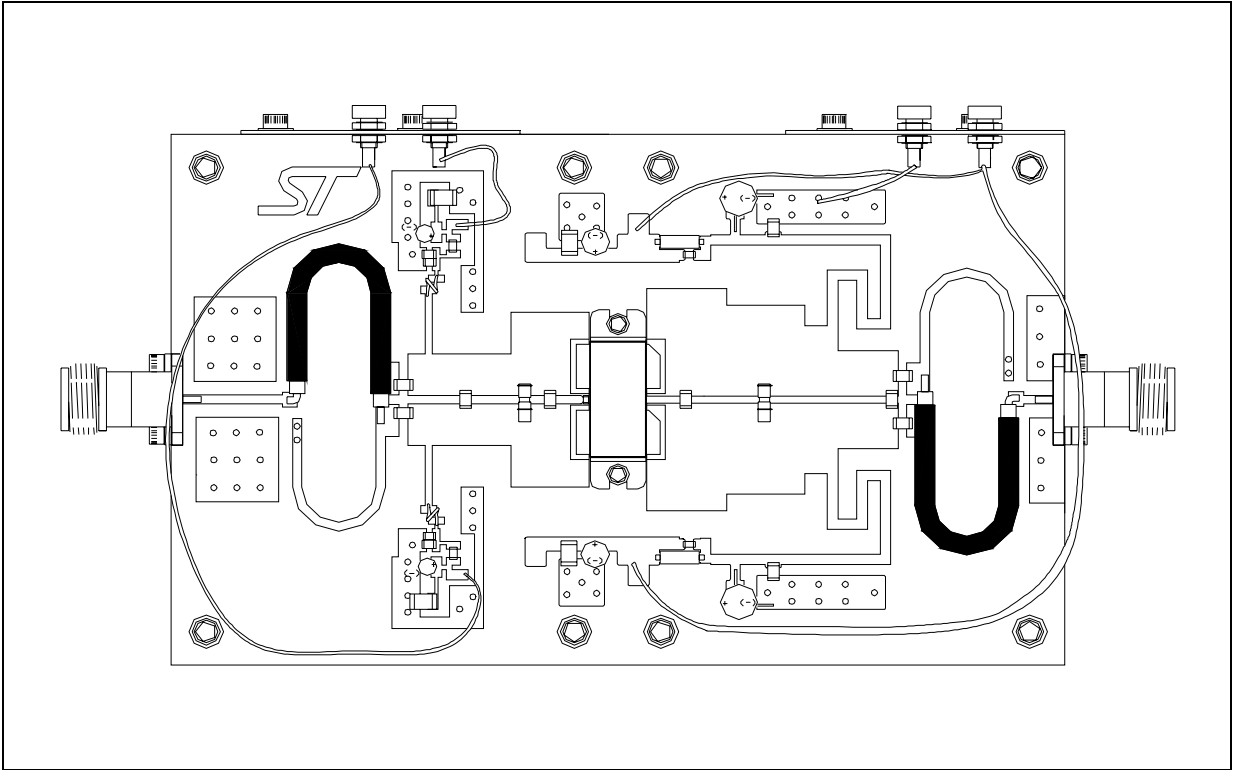
TEST CIRCUIT SCHEMATIC



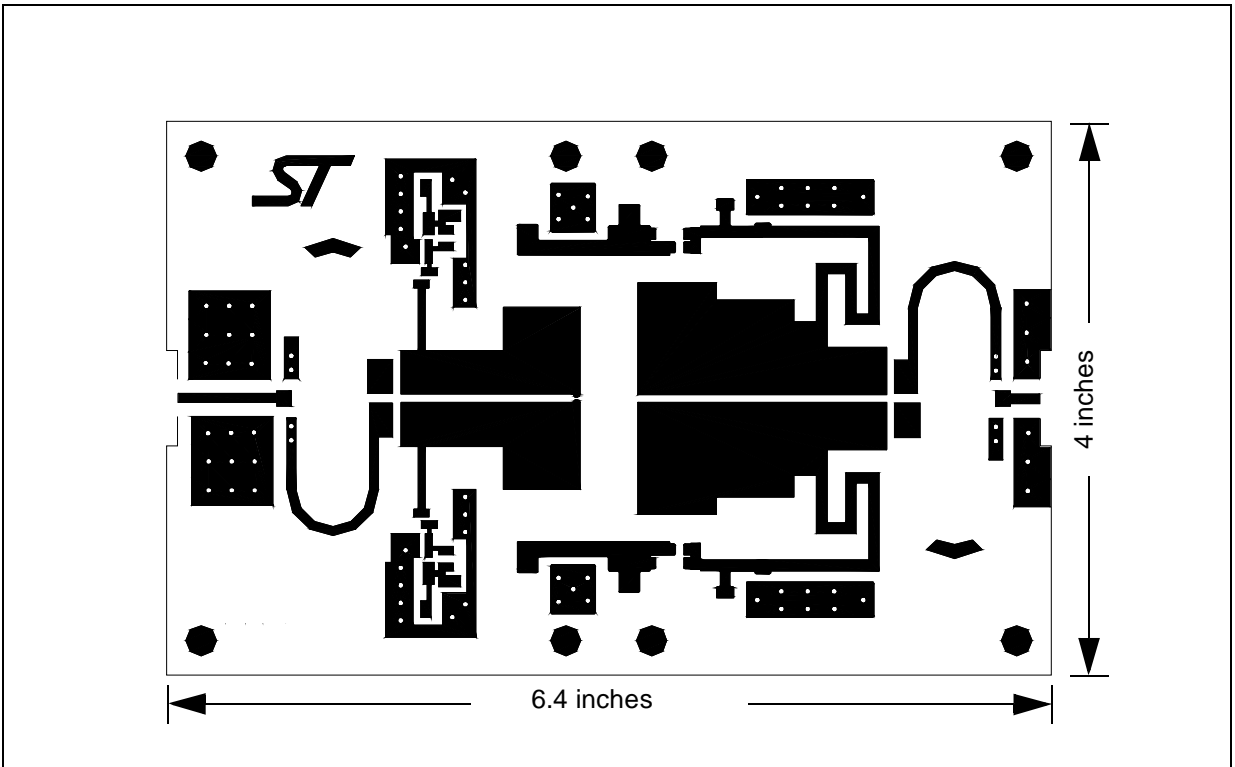
TEST CIRCUIT COMPONENT PART LIST

| | DESCRIPTION |
|--------------------|--|
| C1,C2, C10, C11 | 51 pF ATC 100B SURFACE MOUNT CERAMIC CHIP CAPACITOR |
| C3 | 9.1 pF ATC 100B SURFACE MOUNT CERAMIC CHIP CAPACITOR |
| C4, C8 | 0.6 - 4.5 pF GIGATRIM VARIABLE CAPACITOR |
| C5 | 10 pF ATC 100B SURFACE MOUNT CERAMIC CHIP CAPACITOR |
| C6 | 4.7 pF ATC 100A SURFACE MOUNT CERAMIC CHIP CAPACITOR |
| C7 | 13 pF ATC 100B SURFACE MOUNT CERAMIC CHIP CAPACITOR |
| C9 | 6.2 pF ATC 100B SURFACE MOUNT CERAMIC CHIP CAPACITOR |
| C12, C15, C18, C22 | 91 pF ATC 100B SURFACE MOUNT CERAMIC CHIP CAPACITOR |
| C13, C16, C20, C24 | 10 μ F 50V ALUMINUM ELECTROLYTIC RADIAL LEAD CAPACITOR |
| C14, C17, C21, C25 | 0.1 μ F 500V SURFACE MOUNT CERAMIC CHIP CAPACITOR |
| C19, C23 | 100 μ F 63V ALUMINUM ELECTROLYTIC RADIAL LEAD CAPACITOR |
| R1, R2, R3, R4 | 200 OHM 1/4 W SURFACE MOUNT CHIP RESISTOR |
| R5, R6 | 1.8 OHM 1/4 W SURFACE MOUNT CHIP RESISTOR |
| L1, L2 | CHIP INDUCTOR 10 nH SURFACE MOUNT COIL |
| FB1, FB2 | SURFACE MOUNT EMI SHIELD BEAD |
| B2, B1 | BALUN, 25 OHM, SEMI-RIDGE OD 0.141 2.365 LG COAXIAL CABLE OR EQUIVALENT |
| PCB | WOVEN GLASS REINFORCED / CERAMIC FILLED 0.030" THK $\epsilon_r = 3.48$, 2 Oz ED CU BOTH SIDES |

TEST FIXTURE

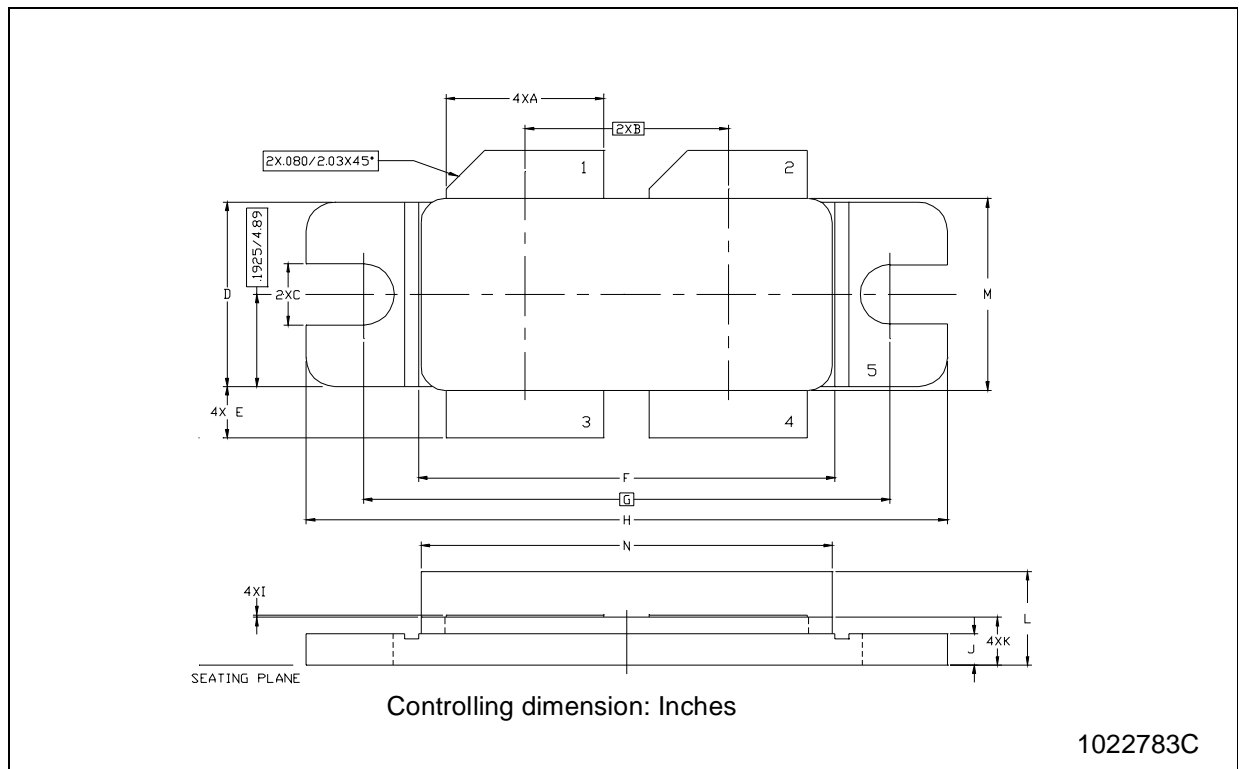


TEST CIRCUIT PHOTOMASTER



M252 (.400 x .860 4L BAL N/HERM W/FLG) MECHANICAL DATA

| DIM. | mm | | | Inch | | |
|------|-------|-------|-------|-------|-------|-------|
| | MIN. | TYP. | MAX | MIN. | TYP. | MAX |
| A | 8.13 | | 8.64 | .320 | | .340 |
| B | | 10.80 | | | .425 | |
| C | 3.00 | | 3.30 | .118 | | .130 |
| D | 9.65 | | 9.91 | .380 | | .390 |
| E | 2.16 | | 2.92 | .085 | | .115 |
| F | 21.97 | | 22.23 | .865 | | .875 |
| G | | 27.94 | | | 1.100 | |
| H | 33.91 | | 34.16 | 1.335 | | 1.345 |
| I | 0.10 | | 0.15 | .004 | | .006 |
| J | 1.52 | | 1.78 | .060 | | .070 |
| K | 2.36 | | 2.74 | .093 | | .108 |
| L | 4.57 | | 5.33 | .180 | | .210 |
| M | 9.96 | | 10.34 | .392 | | .407 |
| N | 21.64 | | 22.05 | .852 | | .868 |



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